

Universal Test Fixture

3680 Series

3680-20: DC to 20 GHz

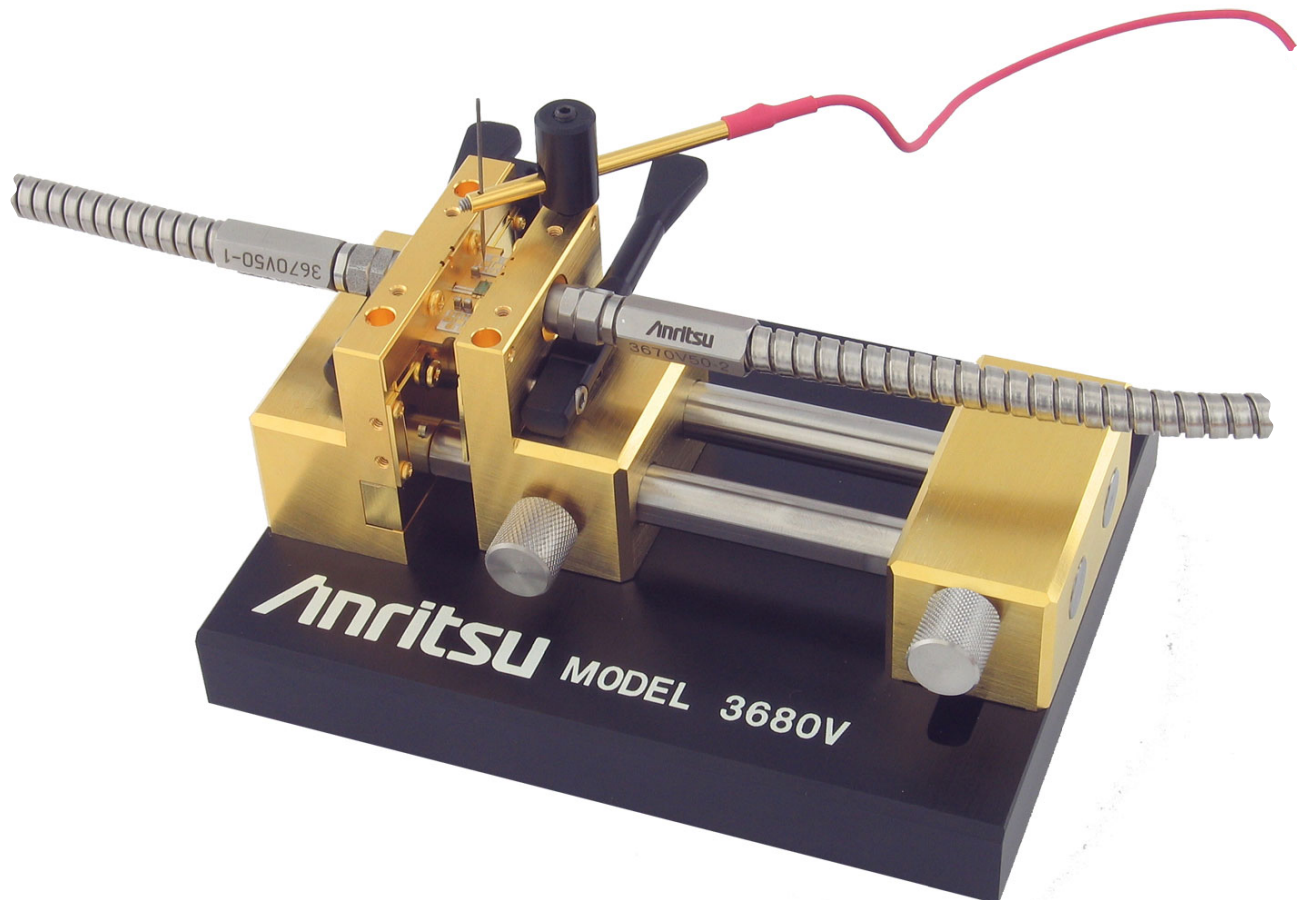
3680K: DC to 40 GHz

3680V: DC to 60 GHz

Introduction

Providing substrate measurement capability for your microstrip or coplanar waveguide designs, the 3680 Series Universal Test Fixtures allow accurate, repeatable transitions from coax to microstrip or coax to coplanar waveguide (CPW). Complete substrate measurement systems comprised of a Universal Test Fixture, a vector or scalar network analyzer, and a "substrate" Calibration Kit can fulfill your microstrip or CPW test needs. Anritsu provides the complete measurement solution, the test fixtures, the calibration kits, and the test equipment for measurements on substrate devices. Our total system responsibility ensures compatible system components, designed to work together properly. Guaranteed system specs provide assurance that your test results are accurate and verifiable.

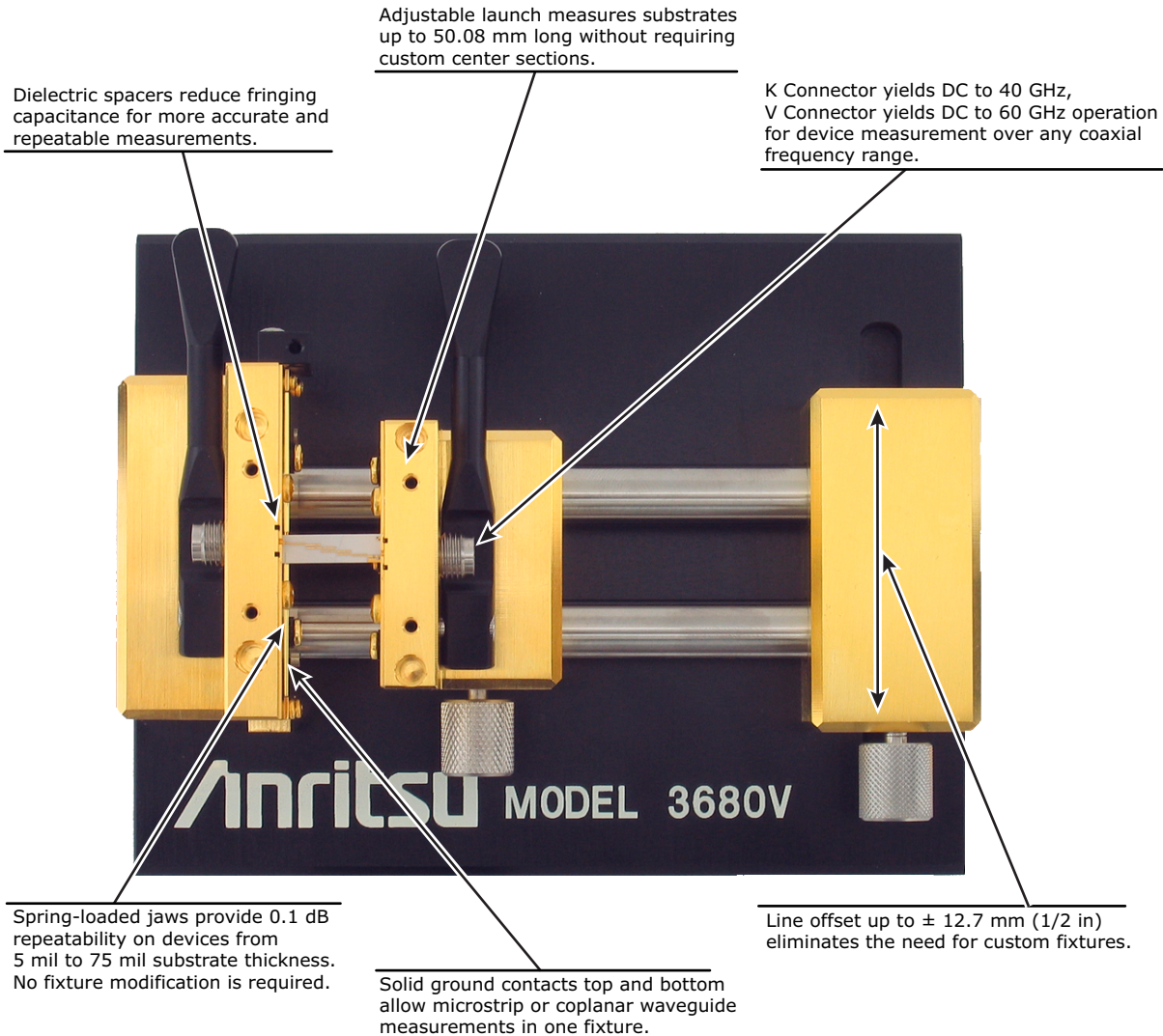
The most critical part of any substrate measurement system is the launching fixture. It must be simple yet flexible, easy to use, and most of all provide accurate, repeatable measurements. Our Universal Test Fixtures are designed to meet these requirements. Three versions of the Universal Test Fixture are available: the 3680-20, DC to 20 GHz; the 3680K, DC to 40 GHz; and the 3680V, DC to 60 GHz. With a Universal Test Fixture you can be sure your measurements are both accurate and repeatable.



Device Description

General Features

The fixture consists of a fixed connector and a movable connector that can be positioned for substrates up to 50.08 mm (2 in) long. No center section is required. The substrate is held in place between spring loaded jaws. This allows the fixture to accommodate different devices without requiring a custom center section for each different length. The unique jaw action ensures solid, repeatable electrical contact. The jaw tension is defined by the force of a spring, independent of human judgement errors. This means the jaw tension will always be the same, providing more repeatable measurements. Dielectric rods behind the jaws accurately position the substrate away from the launch to reduce fringing capacitance and contribute to the fixture's excellent repeatability.



Microstrip or Coplanar Waveguide Measurements

The unique design of the 3680 provides measurement capability for either microstrip or coplanar waveguide (CPW) designs. All that is required is a simple jaw change. The 3680 does the job of two fixtures, saving you time and money. A substrate measurement system with an Anritsu VNA is the only measurement system capable of directly providing microstrip dispersion compensation. Microstrip is a dispersive media - phase shift is not linear with respect to frequency. Our Vector Network Analyzer's ability to compensate for this dispersion can dramatically improve vector measurement accuracy and provide you with the most accurate vector measurements possible.

Offset Measurements

With a 3680 based substrate measurement system, there is not need to force your designs into a straight line or leave your designs untested. The 3680 has the ability to offset lines by as much as $\pm 1/2$ inch. Many designs, such as filters, require parallel traces that are offset. In the past, designers were forced to add extra line lengths, create custom fixtures, or worse, not test offset designs. With the flexibility of the 3680, you can test offset or in-line designs with one setup. Formerly untestable designs can now be tested with ease.

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| Right-Angle Measurements | Testing designs with right-angle connections is made easy. The optional rightangle launcher adds a connection at 90° to the fixture. This lets you test devices with right-angle connections with precision and repeatability corresponding to an in-line measurement. The fixture is designed to fit your device; you don't have to design your device to fit the fixture. The right-angle launcher also provides another benefit - the ability to test multiport devices. With the addition of right-angle launchers, the 3680 can become a three port, or even four port launching fixture. An Anritsu VNA based microstrip measurement system with optional dual source control can interdependently control up to two sources and a receiver, for testing mixers or other frequency conversion devices. Now a microstrip or CPW mixer, converter, or other device can be tested, with the same convenience as a packaged device. |
| 60 GHz Measurements | Anritsu was the first manufacturer to offer a coaxial VNA with continuous 0.04 GHz to 60 GHz measurement capability. With the 3680 Series Universal Test Fixtures, that measurement capability is extended onto the substrate. An Anritsu VNA based substrate measurement system is capable of measurements from 70 kHz to 60 GHz in one setup. And the optional 60 GHz time domain capability provides time or distance measurements with unsurpassed resolution. Discontinuities as close as 1.2 mm on alumina can be resolved. You can measure devices whose performance could previously only be theorized. The 3680V, thanks to the patented V Connector, has excellent return loss and insertion loss from DC to 60 GHz. In a substrate measurement system, that translates to improved accuracy and repeatability, for more accurate characterization of your microstrip or CPW designs. |
| Bias Capability | For active device measurements, the 3680 has bias capability either through the RF connection or through a bias probe. With optional multiple bias probes, you can inject bias into any point on your device under test. The bias probe provides infinite placement resolution and eliminates the need for external bias hardware. Alternately, if your active device is biased through an RF connection, bias tees can be used to combine bias and RF at any launch point. The 3680's flexible bias injection eliminates the need for multiple fixtures, saving you time and money. Up to four bias probes can be accommodated. |
| MMIC Measurements | With the optional MMIC attachment, you can test MMICs and very small components as conveniently as other devices. A MMIC attachment consists of a center carrier, with microstrip lines for launching, and cam-operated pressure rods. The MMIC component is placed on the center carrier between microstrip lines. (Machinable center carrier blocks are available for your custom designs.) Contact with the component is made with spring tabs, for reliability and damage protection. The unique design of the MMIC attachment assures solid, repeatable measurements on any small device. An Anritsu substrate measurement system can fulfill all your substrate measurement needs including, with a MMIC attachment, very small substrates and MMICs. |
| Calibration/Verification Kits | A full complement of calibration kits for microstrip or coplanar waveguide are available. Standard Open Short Load (OSL) and Line Reflect Line (LRL) calibration components are included. The substrates for these cal kits are carefully selected for proper impedance and consistency, to provide the most accurate measurements possible. Included with every cal kit is a Beatty standard (standard mismatch) and a 20 dB offset termination. Now you can verify, in the fixture, the quality of your calibrations. This verification ensures the validity of your device measurements. |

Mechanical Specifications

3680 Series Universal Test Fixture

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| Substrate Types Supported | Microstrip or Coplanar Waveguide |
| Overall Size | 3680-20: 4.9 W x 7 L x 2.5 H 3680K and 3680V: 4W x 5L x 2.5H in |
| Substrate Length | 3680-20: 0.2 in (0.5 cm) minimum, 4.0 in (10 cm) maximum 3680K and 3680V: 0.2 in (0.5 cm) minimum, 2.0 in (5 cm) maximum |
| Substrate Width | No limit on maximum width, 0.05 in (1.2 mm) minimum |
| Substrate Thickness | 0.005 in (0.12 mm) minimum 0.075 in (1.9 mm) maximum |
| Line Offset | 3680-20: ± 1.0 in (2.5 cm) maximum 3680K and 3680V: ± 0.5 in (1.2 cm) maximum |
| Input and Output Connectors | 3680-20: 3.5 mm Female 3680K: K Connector Female 3680V: V Connector Female |

36801 K and V Right-Angle Launcher

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| Distance from In-Line Connector, Axial | 0.4 in (1 cm) minimum 1.7 in (4.3 cm) maximum |
| Distance from In-Line Connector, Offset | 0.0 in minimum 1.0 in (2.54 cm) maximum |

36802 MMIC Attachment

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| Substrate Thickness | Designed for 0.010 in substrates (Block can be modified for other thicknesses.) |
| Test Substrate Length | 0.05 in (0.12 cm) minimum 0.46 in (1.17 cm) maximum |
| Line Offset | ± 0.5 in (1.2 cm) maximum |

Electrical Specifications

| Model | Universal Test Fixture | | | Right-Angle Launcher | | MMIC Attachment |
|---|------------------------|----------|----------|----------------------|----------|-----------------|
| | 3680-20 | 3680K | 3680V | 36801K | 36801V | 36802 |
| Frequency Range (GHz) | DC to 20 | DC to 40 | DC to 60 | DC to 40 | DC to 60 | DC to 60 |
| Return Loss (Coax Calibration, Typical, dB) | | | | | | |
| 0.04 GHz to 20 GHz | > 17 | > 17 | > 17 | > 16 | > 16 | > 12 |
| 20 GHz to 40 GHz | | > 14 | > 14 | > 12 | > 12 | > 8 |
| 40 GHz to 60 GHz | | | > 8 | | > 7 | > 6 |
| Repeatability of Insertion Loss (dB) | | | | | | |
| 0.04 GHz to 20 GHz | < ±0.10 | < ±0.10 | < ±0.10 | < ±0.15 | < ±0.15 | < ±0.20 |
| 20 GHz to 40 GHz | | < ±0.20 | < ±0.20 | < ±0.25 | < ±0.25 | < ±0.40 |
| 40 GHz to 60 GHz | | | < ±0.30 | | < ±0.40 | < ±0.60 |

Temperature range -20 °C to +70 °C

Test Port Characteristics

(When used with an Anritsu Vector Network Analyzer)
 Test port characteristics apply after optimum 12-term calibration, using an Anritsu 36804 Calibration Kit.
 36804B-10M (0.04 to 50 GHz)
 36804B-15M (0.04 to 30 GHz)
 36804B-25M (0.04 to 15 GHz)
 36804-25C (0.04 to 20 GHz)

| Frequency (GHz) | Directivity (dB) | Source Match (dB) | Load Match (dB) |
|-----------------|------------------|-------------------|-----------------|
| 0.04 | > 28 | > 24 | > 28 |
| 2.0 | > 34 | > 32 | > 34 |
| 20 | > 28 | > 32 | > 28 |
| 30 | > 28 | > 26 | > 28 |
| 40 | > 28 | > 26 | > 28 |
| 50 | > 26 | > 22 | > 26 |

Ordering Information

Universal Test Fixtures

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|---------|-------------------------------|
| 3680-20 | 20 GHz Universal Test Fixture |
| 3680K | 40 GHz Universal Test Fixture |
| 3680V | 60 GHz Universal Test Fixture |

Accessories

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|------------------------|--|
| 36801K | 40 GHz Right-Angle Launcher |
| 36801V | 60 GHz Right-Angle Launcher |
| 36802 | MMIC Attachment |
| 36803 | Bias Probe |
| 36805 Series Launchers | 36805 series includes (4) substrate launchers for the 36802 MMIC attachment. |
| 36805-10M | 10 mil launchers |
| 36805-15M | 15 mil launchers |
| 36805-25M | 25 mil launchers |

Calibration/Verification Kits

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|------------|---|
| | 36804 Calibration/Verification Kits |
| 36804B-10M | 10 mil Microstrip Calibration/Verification Kit, DC to 50 GHz ¹ |
| 36804B-15M | 15 mil Microstrip Calibration/Verification Kit, DC to 30 GHz ¹ |
| 36804B-25M | 25 mil Microstrip Calibration/Verification Kit, DC to 15 GHz ¹ |
| 36804-25C | 25 mil CPW Calibration/Verification Kit, DC to 20 GHz (Includes CPW jaws) |

1. 36804 series calibration/verification kits come with individual calibration coefficients printed on a label that is located inside the top cover under the foam padding. Contact Anritsu sales for calibration related questions.



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